Search Notes			

Application/Control	No. Applicant(s)/Patent under Reexamination
10/774,535	LEE ET AL.
Examiner	Art Unit

Leith A. Al-Nazer

SEARCHED			
Class	Subclass	Date	Examiner
315	169.1- 169.4	6/10/2005	LA
313	498-505	6/10/2005	LA
345	77, 80	6/10/2005	LA
345	83, 204	6/10/2005	LA
345	690	6/10/2005	LA

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NO (INCLUDING SEARCH	TES STRATEGY	)
·	DATE	EXMR
EAST text search (see "Examiner Search Notes")	6/10/2005	LA